## A b-initio simulation of photoinduced transform ation of sm all rings in am orphous silica

Davide Donadio

Computational Science, Department of Chemistry and Applied Biosciences, ETH Zurich USICampus, Via Giuseppe Bu 13, CH-6900 Lugano, Switzerland

Marco Bernasconi

Dipartim ento di Scienza dei Materiali and INFM, Universita di Milano-Biccoca, via Cozzi 53, I-20125 Milano, Italy

W e have studied the photoinduced transform ation of sm all rings (3-m em bered) in am orphous silica by Car-Parrinello simulations. The process of ring opening leading to the formation of a couple of param agnetic centers, namely an E' and a non-bridging-oxygen hole center (NBOHC), has been proposed experimentally to occur in silica exposed to  $F_2$  laser irradiation (at 7.9 eV). By using a new scheme for the simulation of rare events in ab-initio molecular dynamics (Iannuzzi, Laio and Parrinello, Phys. Rev. Lett. 90, 238303 (2003)), we have identied the transformation path for the opening of a 3-m embered ring induced by a self-trapped triplet exciton, the m igration of NBOHC and formation of a couple of stable E' and NBOHC param agnetic defects.

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Extensive experimental and theoretical studies have been devoted to point defects in am orphous silica due to their relevance in the degradation of SiD<sub>2</sub>-based electronic devices and in the photosensitivity of optical bers [1]. For instance, it is well established that the possibility to change the refractive index and write B ragg gratings in optical bers by UV illumination is connected to the photoinduced transformation of pre-existing defects or the formation of new ones. The formation of defects in am orphous silica upon  $F_2$  excine relaxer irradiation is also held responsible for the degradation of lenses for optical lithography in semiconductor technology [2].

In a recent experim ental work Hosono et al. [2] proposed that the main channel for color center form ation in silica exposed to radiation of an F<sub>2</sub> excimer laser (7.9 eV, well below the Tauc band gap of a-SiO<sub>2</sub>) is the generation of an E' center and a non-bridging-oxygen hole center (NBOHC) from one-photon excitation and breaking of strained bonds in sm all (3-or 4-m em bered) rings. The experimental evidence comes from combined Electron Param agnetic Resonance (EPR), Ram an and optical spectroscopy m easurem ents which show a correlation between the intensities of the R am an lines associated to the breathing m odes of 3- and 4-m em bered rings (D  $_1$  and D  $_2$ lines) in samples with di erent xation temperatures and the appearance of EPR and optical absorption signals assigned to E' and NBOHC radicals. From these correlations Hosono et al. inferred that one-photon absorption processes at 7.9 eV generate excitons self-trapped on the small rings which would lead to ring opening and pair formation of E' and NBOHC defects as shown in Fig. 1.

In this paper we report the results of ab-initio simulations of the photoinduced processes leading to the opening of sm all rings in a-SiO<sub>2</sub> aim ing at providing theoretical support to the mechanism of E'-NBOHC pair genera-

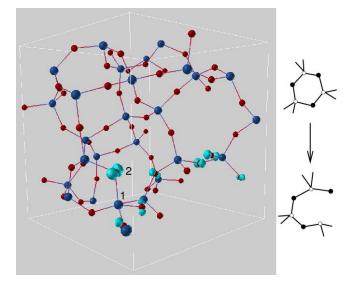


FIG. 1: Left panel: electron density of the hole of the triplet exciton self-trapped on a 3-m embered ring in a 81atom s m odel of a-SiO<sub>2</sub>. The contour value on the electron density plot is 0.125 a.u.. The Kohn-Sham orbital is mostly localized on the oxygen atom O (2). Right panel: path for the pair generation of the E' and NBOHC radicals upon photoexcitation of a 3-m embered ring as proposed in Ref. [2].

tion proposed experimentally. The main outcome of the simulation is that the conguration of the two paramagnetic centers proposed experimentally and shown in Fig. 1 is metastable on the excitate state, but the ring spontaneously closes once the system is brought back on the electronic ground state. However, a stable E'-NBOHC pair is found via a further migration of the NBOHC.

Ab-initio Car-Parrinello [3, 4, 5] m olecular dynam ics (MD) simulations have been performed within the fram e-

work of density functional theory in the local spin density approxim ation supplem ented by generalized gradient corrections [6, 7]. Norm conserving pseudopotentials [8], plane wave expansion of Kohn-Sham (KS) orbitals up to a kinetic energy cuto of 70 Ry, a ctitious electronic mass of 800 a.u. and a time step of 0.15 fs have been used. The photoinduced transform ations have been sim ulated by adiabatic Bom-Oppenheim er MD on the lowest triplet  $(T_1)$  excited state energy surface. Although the photoinduced reaction would occur on the singlet excited state, M D on the T<sub>1</sub> excited energy surface is more easily a ordable within our fram ework and would provide transformation paths that also shed light on the processes induced by the singlet excitons as we have already demonstrated in a previous work on the photoinduced interconversion of oxygen de cient centers in  $a-SiO_2$  [9].

Periodic models of a-SiO  $_2$  containing 81 atom s at the experim ental density of 2.2 g/cm<sup>3</sup> have been generated by quenching from the melt in classical MD, adopting the em piricalpair potential by van Beest et al. [10]. Quenching tim es as long as 5 ns have been used in the classical simulations in order to generate models with a small num ber of 3- and 4-m em bered rings. Three m odels have been generated, one with one 3- and four 4-m em bered rings, a second with one 3- and ve 4-m embered rings, and a third one with no 3-and one 4-m em bered ring. The classical models have been then annealed at 600 K for 1.5 ps by ab-initio MD. This procedure has been already demonstrated to provide models of a-SiO2 with good structural, elastic and dielectric properties [11, 12, 13]. By exciting the system on the lowest triplet state, we have found that for the rst among the models considered the hole of the exciton is partially localized on the 3m em bered ring. The self-trapped triplet exciton is shown in Fig. 1. Hereafter all the simulations presented would refer to this latter model. The triplet exciton induces a slight lengthening of the Si(1)-O (2) bond in Fig. 1 by 0.03 A, but the ring is still locally stable. The transform ation leading to the opening of the ring turns out to be an activated process with an energy barrierm uch larger than the therm alenergy. Thus it would not occur spontaneously on the time scale of Car-Parrinello simulations, few tens ofps long. In order to overcom e this lim itation, we have exploited a new technique [14] recently devised to simulate rare events within Car-Parrinello MD. The method is based on a coarse-grained dynamics in the space of few reaction coordinates, biased by a history-dependent potential which drives the system toward the lowest transition state [14, 15, 16]. The total energy of the locally stable con gurations and transition states found along the transform ation path have been then re ned by constrained geom etry optim ization [18]. The activation energies of the di erent processes have been then estim ated, although in principle also the entropic contributions to the activation free energies could be computed within the method of Ref. [14]. Due to the relatively large size of

our sinulation cell and the long sinulation time needed to get accurate free energy estimates, we have restricted ourselves to the calculation of activation energies and not free energies. Entropic e ects are small anyway for the breaking of siloxane bonds at room temperature as shown in Ref. [19].

Following the scheme of Ref. [14], the collective reaction coordinates S (fR  $_{\rm I}$ g), function of the ionic positions R  $_{\rm I}$ , de ne a set of associated collective variables s which are treated as new dynamical variables. The extended system is described by the Lagrangian

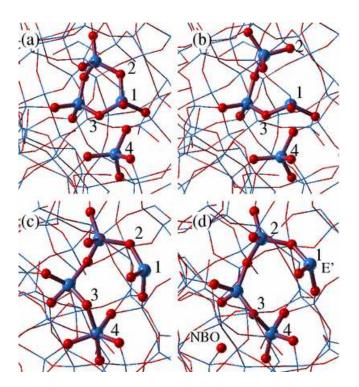
$$L = L_{o} + \frac{X}{2} \frac{1}{2}M \frac{s^{2}}{2} + \frac{X}{2}K S (fR_{I}g) s^{2}(1)$$
$$V (t; fs g);$$

where  $L_o$  is the Car-Parrinello Lagrangian, the second term is the ctitious kinetic energy of the s's, the third term is a harmonic potential that restrains the value of the collective coordinates S (fR Ig) to the corresponding dynamic collective variables s . V (t; fs g) is the Gaussian-like history dependent potential de ned in ref. [14].

In a rst simulation, we have used a single collective variable which provides a measure of the length of the Si(1)-O (1) bond (cfr. Fig. 1) which is lengthened upon excitation on the triplet state. Namely, we have chosen the coordination number  $n_{Si(1) \circ (2)}$  between atom s Si(1) and O(2). Following Ref. [14], the coordination number between atom a and atom s b is de ned as  $n = \frac{1}{2} \left(\frac{r_{ab}}{d}\right)^{6}$  where n is the distance between the  $_{b}\frac{1}{1}\frac{\left(\frac{2\pi}{d}\right)^{14}}{\left(\frac{r_{ab}}{d}\right)^{14}}$  where  $r_{ab}$  is the distance between the n<sub>a</sub> = two atoms and scaling factor d is chosen as d=2.2 A.  $n_a$ estim ates the number of atom s b within the bond cuto distance to atom a and decays smoothly for larger distances. Recent investigations have shown that the best e ciency of the method would be achieved in our case when the collective variable has a characteristic frequency ( k=M ) of the same order of m agnitude as the Si-O stretching mode [17]. A coordingly, we have chosen  $M = 1.82 \ 10^5 \ au$ . and  $k = 1 \ au$ . in Eq. (1) ( k=M

 $10^{14}$  s<sup>1</sup>). The parameters which de ne the historydependent Gaussian potential in Eq. (3) of Ref. [14] are s<sup>2</sup> = 0:08 and W = 0:002 Hartree. M D simulations have been performed at 300 K [20].

Under the e ect of the driving history-dependent potential the ring opens in 4.5 ps leading to the con guration reported in Fig. 2b. Its energy, obtained by geom etry optimization, is -0.27 eV with respect to the energy of the closed ring on the  $T_1$  excited state which is chosen hereafter as our zero of energy. At this point the electron of the triplet exciton is self-trapped on Si(1). In the con guration of Fig. 2b two param agnetic defects are form ed (an E' center on Si(1) and a NBOHC on 0 (2), 3 A far apart) by breaking the Si(1)-0 (2) siloxane bond and overcom ing an activation barrier of 0.38



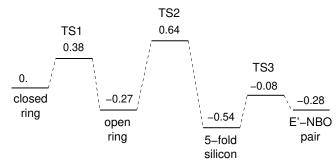


FIG.3: Energies of the optim ized localm inim a corresponding to the con gurations of Fig. 2. Closed ring, open ring, 5-fold silicon and E'NBOHC pair refer to panels a, b, c and d of Fig. 2, respectively. The energy and geom etry of the transition states TS1, TS2 and TS3 are obtained from constrained geom etry optim ization [18] by using as reaction coordinate respectively the distance Si(1)-0 (2), Si(1)-0 (3) or Si(4)-NBO in Fig. 2.

FIG.2: Snapshots of the locally stable con gurations found along the path that leads to the form ation of an E'-NBOHC pair from the photoinduced opening of a 3-m embered ring. The atom s involved in the transform ation are represented by spheres and connected by thicker sticks. (a) The 3-m embered ring excited on the  $T_1$  state. (b) The adjacent E'-NBOHC defect pair. (c) The E' center and the 5-coordinated silicon atom . (d) The stable E'-NBOHC pair.

eV. The energy barrier is obtained from constrained abinitio M D simulations [18] at di erent values of a reaction coordinate chosen as the Si(1)-Si(2) distance. The con-

guration in Fig. 2b is locally stable on the  $T_1$  excited state, but by de-exciting the system on the ground state  $(S_{\circ})$ , we have observed a charge transfer from the E ' center to the NBOHC which leads to a spontaneous closure of the ring [21]. Therefore, the two param agnetic defects in the con guration of Fig. 2b are not stable in the ground state and cannot be assigned to the EPR signals observed experim entally. W e m ay envisage to stabilize the E'-NBOHC pair by reducing the interaction between the two radicals to be realized by allowing a migration of one of two param agnetic centers. In order to identify this process we have added a second collective variable in Eq. (1), de ned as the coordination number  $n_{Si(1)} \circ (3)$ between atom s Si(1) and O (3) in Fig. 2a. The presence of both the  $n_{Si(1) \circ (2)}$  and  $n_{Si(1) \circ (3)}$  collective variables allows to explore di erent paths for the ring opening. The parameters M, k,  $s^2$  and W are the same as before. In this second simulation the system initially follows the same path seen in the previous one which means

that the Si(1) - O(2) bond is weaker than the Si(1) - O(3)one. However, as the simulation proceeds, the historydependent potential drives the system away from the localmiminum of Fig. 2b. First, the Si(1)-O (2) bond is recovered and then a new conform ation of the open ring is form ed by breaking the Si(1)-O (3) bond. The NBOHC generated in this way (on 0 (3)) oats around and nally form s a new bond with Si(4) which becomes 5-fold coordinated. This process has a higher activation barrier (0.64 eV) but leads to a con guration (Fig. 2c) which is locally stable with a total energy of -0.54 eV. From this con guration it is now envisageable to generate a new NBOHC by breaking one of the ve Si(4)-O bonds. To identify which Si(4)-O bond is most prone to break, we have started a third simulation from the con guration of Fig. 2c with the total coordination number  $n_{{\rm S\,i}(4)~0}~$  as collective variable. The nal structure of this latter process is shown in Fig. 2d. Its total energy is -0.28 eV and the activation barrier for the form ation of the NBOHC is 0.46 eV (Fig. 3). The E' and the NBOHC centers in this

nalcon guration are distant enough (6.3A) to prevent the charge transfer upon de-excitation on the  $S_o$  state. As the two radicals do not interact each other, there is no singlet-triplet splitting and the EPR signals are supposed to be equal to those of the isolated param agnetic centers. The path identi ed by the localm inim a of Figs. 2a-c represents thus a viable mechanism for the opening of the ring and m igration of the NBOHC suitable to provide a pair of stable param agnetic defects. The total trajectory starting from the initial con guration of Fig. 2a and reaching the nalcon guration of the stable E'-NBOHC pair in Fig. 2d is 2.7 ps long . The energies of the con gurations in Fig. 1 and of the transition states separating the di erent localm inim a are collected in the scheme of Fig. 3. The geometry of the transition state

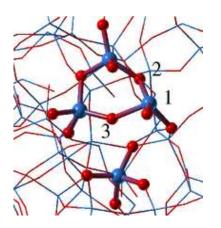


FIG. 4: G eom etry of the transition state TS2 of Fig. 3. The distances between the silicon atom Si(1) and the oxygen atom s O (2) and O (3) are 1.80 A and 2.05 A, respectively. The tetrahedron form ed by atom Si(1) is highly distorted and undergoes a puckering once a NBOHC is form ed on O (3) (cfr. Fig. 2c). As a consequence the resulting E' center that does not point tow ards the NBOHC.

leading to the 5-fold coordinated Si is reported in Fig. 4. We rem ark that the recovery of the Si(1)-O (2) bond moving from con guration in Fig. 2b to the transition state in Fig. 4 does not restore the initial con guration of the closed ring (Fig. 2a). No interm ediate localm inim a from Fig. 2b to Fig. 2c is found. The activation barrier for the whole process (the energy of the highest transition state) is 0.64 eV, su ciently low to make this transform ation channel viable at room tem perature. These values for the activation energies are supposed to depend on the local environment and strain of the small ring. As a consequence only a fraction of the small rings are expected to undergo this transform ation upon photoexcitation.

In summary, we have identied the transformation path for the opening of a 3-membered ring induced by a self-trapped triplet exciton. Once open in the excited electronic state, the 3-membered ring gives rise to a couple of strongly interacting E' and NBHOC defects, which recombine quickly after electronic de-excitation. However, a simple path with a low energy barrier (0.64 eV) has been identiced for the migration of the NBOHC which leads to the formation of a couple of stable E' and NBOHC paramagnetic centers. The simulations thus provide a theoretical support to the interpretation of the experimental data in Ref. [2] on the formation of color centers in a-SiO<sub>2</sub> by F<sub>2</sub> laser irradiation.

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corresponding author: ddonadio@ phys.chem.ethz.ch

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- [20] C onstant tem perature is enforced by velocity rescaling at the target tem perature with a tolerance of 10 % .
- [21] We have performed additional calculations on cluster m odel by using the B 3LY P [7, 22] functional in order to check the e ect of the functional on the E'! NBOHC charge transfer mechanism identi ed in the simulation. In fact, the BLYP functional is expected to underestim ate the Hubbard-U parameter on the oxygen radical due to incom plete correction of the self-interaction. On the contrary the self-interaction is exactly cancelled within the B3LYP functional. We have considered two clusters Si(OSH3)3 and O(SH3) at di erent Si-Sidistances. We have found that the charge transfer occurs for E'-NBOHC distances below 5 A for the B3LYP functional and below 5.4 A for the BLYP functional. The calculations have been performed with the code Gaussian 98 [23] and the 6-311+G basis set which provides a good description of point defects in silica [24].
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